Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/660,858	PHAN ET AL.
Examiner	Art Unit
Peter J. Vrettakos	3739

SEARCHED				
Class	Subclass	Date	Examiner	
606	27-52	10/20/2005	PV	
128	898	10/20/2005	PV	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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